Surface Mount - 400V - 800V







Description

The MAC12x is designed for high performance full-wave AC control applications where high noise immunity and commutating di/dt are required.

Features

- Blocking Voltage to 800 Volts
- On-State Current Rating of 12 Amperes RMS at 70°C
- Uniform Gate Trigger Currents in Three Quadrants, Q1, Q2,
- High Immunity to dv/dt 250 V/µs Minimum at 125°C
- High Commutating di/dt 6.5 A/ms Minimum at 125°C
- Industry Standard TO-220
- High Surge Current Capability - 100 Amperes
- These Devices are Pb-Free and are RoHS Compliant

Additional Information



Resources



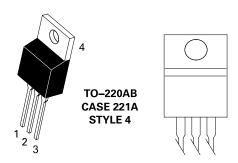


Samples

Functional Diagram



Pin Out



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Maximum Ratings (TJ = 25°C unless otherwise noted)

| Rating | Symbol | Value | Unit | |
|---|--------|--|-------------------|-------|
| Peak Repetitive Off-State Voltage (Note 1) MAC12D MAC12M (Gate Open, Sine Wave 50 to 60 Hz, $T_J = 40^{\circ}$ to 125°C) MAC12N | | V _{DRM} , V _{RRM} | 400 600 800 | V |
| On-State RMS Current (Full Cycle Sine Wave, 60 Hz, $T_c = 7$ | 0°C) | I _{T (RMS)} | 12 | А |
| Peak Non-Repetitive Surge Current (One Full Cycle Sine Wave, 60 Hz, T _i = 125°C) | | I _{TSM} | 100 | А |
| Circuit Fusing Consideration (t = 8.3 ms) | | l²t | 41 | A²sec |
| Peak Gate Power (Pulse Width \leq 1.0 μ s, $T_c = 80$ °C) | | P _{GM} | 16 | W |
| Average Gate Power (t = 8.3 ms, T_c = 80°C) | | P _{G(AV)} | 0.35 | W |
| Operating Junction Temperature Range | | T_{J} | -40 to +125 | °C |
| Storage Temperature Range | | T _{stg} | -40 to +150 | °C |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the

Thermal Characteristics

| Rating | | Symbol | Value | Unit |
|--|---|--------------------------------------|-------------|------|
| Thermal Resistance, | Junction-to-Case (AC) Junction-to-Ambient | R _{ejc} R _{eja} | 2.2 62.5 | °C/W |
| Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds | | T_L | 260 | °C |

Electrical Characteristics - OFF (TJ = 25°C unless otherwise noted; Electricals apply in both directions)

| Characteristic | | Symbol | Min | Тур | Max | Unit |
|---|------------------------|--------------------|-----|-----|------|------|
| Peak Repetitive Blocking Current | T ₁ = 25°C | I _{DRM} , | - | - | 0.01 | m Λ |
| $(V_D = V_{DRM} = V_{RRM}$; Gate Open) | T _J = 125°C | IRRM | - | - | 2.0 | mA |

Electrical Characteristics - ON (TJ = 25°C unless otherwise noted; Electricals apply in both directions)

| Characteristic | | Symbol | Min | Тур | Max | Unit |
|---|--------------|-----------------|-----|------|------|------|
| Peak On–State Voltage (Note 2) ($I_{TM} = \pm 11 \text{ A}$) | | V_{TM} | - | - | 1.85 | V |
| Gate Trigger Current | MT2(+), G(+) | | 5.0 | 13 | 35 | mA |
| (Continuous dc) | MT2(+), G(-) | I _{GT} | 5.0 | 13 | 35 | |
| $(V_{D} = 12 \text{ V}, \text{ R}_{L} = 100 \Omega)$ | MT2(-), G(-) | | 5.0 | 13 | 35 | |
| Holding Current ($V_D = 12 \text{ V}$, Gate Open, Initiating Current = $\pm 150 \text{ mA}$ |)) | I _H | - | 20 | 40 | mA |
| | MT2(+), G(+) | IL | _ | 20 | 50 | mA |
| Latching Current $(V_D = 24 \text{ V}, I_G = 35 \text{ mA})$ | MT2(+), G(-) | | _ | 30 | 80 | |
| (v _D = 24 v, i _G = 33 mm) | MT2(-), G(-) | | _ | 20 | 50 | |
| 0 . 7: | MT2(+), G(+) | | 0.5 | 0.78 | 1.5 | |
| Gate Trigger Voltage $(V_D = 12 \text{ V}, R_I = 100 \Omega)$ | MT2(+), G(-) | $V_{\rm GT}$ | 0.5 | 0.70 | 1.5 | V |
| (v _D = 12 v, 11 _L = 100 12) | MT2(-), G(-) | | 0.5 | 0.71 | 1.5 | |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different

2. Indicates Pulse Test: Pulse Width \leq 2.0 ms, Duty Cycle \leq 2%



Recommended Operating Conditions may affect device reliability.

1. V_{DBM} and V_{BBM} for all types can be applied on a continuous basis. Ratings apply for zero or negative gate voltage; however, positive gate voltage shall not be applied concurrent with negative potential on the anode. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the devices are exceeded.

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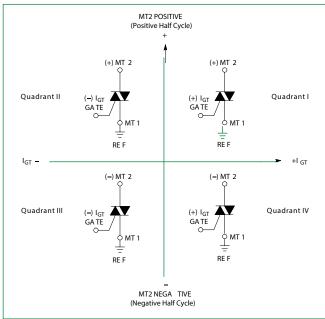
Dynamic Characteristics

| Characteristic | Symbol | Min | Тур | Max | Unit |
|--|----------------------|-----|-----|-----|------|
| Rate of Change of Commutating Current See Figure 10. ($V_D = 400 \text{V}$, $I_{TM} = 4.4 \text{A}$, Commutating dv/dt = 18 V/µs,Gate Open, $T_J = 125 ^{\circ}\text{C}$, f = 250 Hz, No Snubber) | di/dt _(C) | 6.5 | - | - | A/ms |
| Critical Rate of Rise of Off-State Voltage $(V_D = Rated V_{DRM}, Exponential Waveform, Gate open, T_J = 125°C)$ | dV/dt | 250 | 500 | _ | V/µs |
| Repetitive Critical Rate of Rise of On-State Current IPK = 50 A; PW = 40 µsec; diG/dt = 200 mA/µsec; f = 60 Hz | di/dt | - | - | 10 | A/µs |

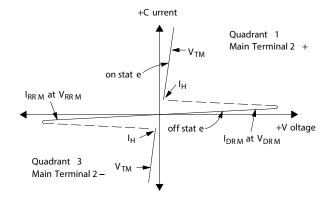
Voltage Current Characteristic of SCR

| Symbol | Parameter |
|-----------------------|---|
| V_{DRM} | Peak Repetitive Forward Off State Voltage |
| I _{DRM} | Peak Forward Blocking Current |
| $V_{_{\mathrm{RRM}}}$ | Peak Repetitive Reverse Off State Voltage |
| I _{RRM} | Peak Reverse Blocking Current |
| V_{TM} | Maximum On State Voltage |
| l _u | Holding Current |

Quadrant Definitions for a Triac



All polarities are referenced to MT1.
With in –phase signals (using standard AC lines) quadrants I and III are used



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Figure 1. Typical Gate Trigger Current vs Junction Temperature

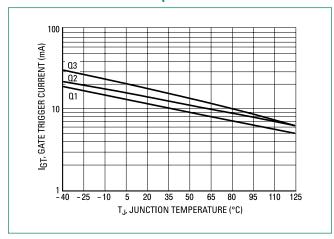


Figure 3. Typical Holding Current vs Junction Temperature

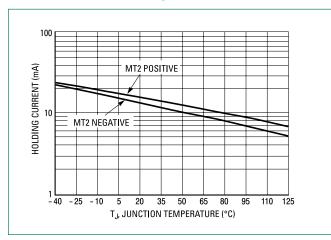


Figure 5. Typical RMS Current Derating

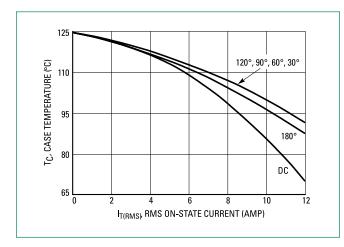


Figure 2. Typical Gate Trigger Voltage vs Junction Temperature

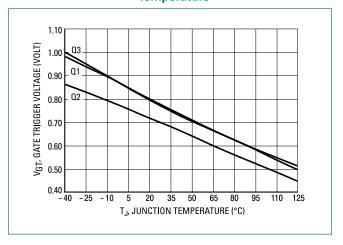


Figure 4. Typical Latching Current vs Junction Temperature

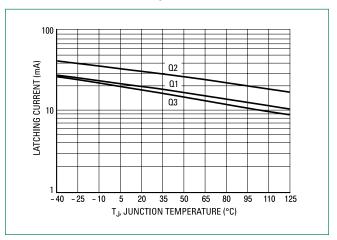
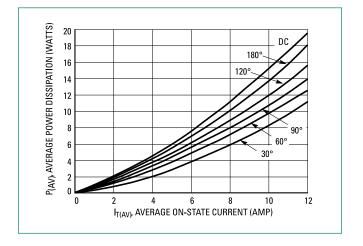


Figure 6. On-State Power Dissipation





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Figure 7. Typical On-State Characteristics

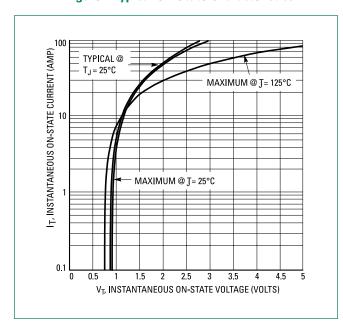
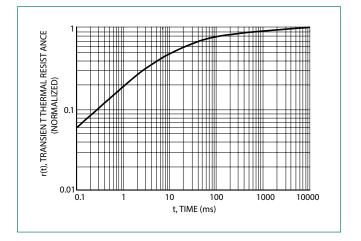


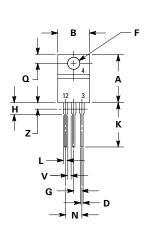
Figure 8. Typical Thermal Response

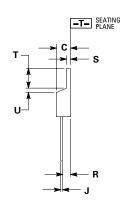




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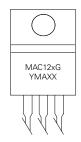
Dimensions





Part Marking System





x =D, M, or N Y =Year

M =Month A =Assembly Site

XX =Lot Serial Code

G =Pb-Free Package

| Dim | Inches | | Millin | neters |
|-----|--------|-------|--------|--------|
| Dim | Min | Max | Min | Max |
| Α | 0.590 | 0.620 | 14.99 | 15.75 |
| В | 0.380 | 0.420 | 9.65 | 10.67 |
| С | 0.178 | 0.188 | 4.52 | 4.78 |
| D | 0.025 | 0.035 | 0.64 | 0.89 |
| F | 0.142 | 0.147 | 3.61 | 3.73 |
| G | 0.095 | 0.105 | 2.41 | 2.67 |
| Н | 0.110 | 0.130 | 2.79 | 3.30 |
| J | 0.018 | 0.024 | 0.46 | 0.61 |
| K | 0.540 | 0.575 | 13.72 | 14.61 |
| L | 0.060 | 0.075 | 1.52 | 1.91 |
| N | 0.195 | 0.205 | 4.95 | 5.21 |
| Q | 0.105 | 0.115 | 2.67 | 2.92 |
| R | 0.085 | 0.095 | 2.16 | 2.41 |
| S | 0.045 | 0.060 | 1.14 | 1.52 |
| Т | 0.235 | 0.255 | 5.97 | 6.47 |
| U | 0.000 | 0.050 | 0.00 | 1.27 |
| V | 0.045 | | 1.15 | _ |
| Z | | 0.080 | | 2.04 |

| Pin Assignment | | | |
|----------------|-----------------|--|--|
| 1 | Main Terminal 1 | | |
| 2 | Main Terminal 2 | | |
| 3 | Gate | | |
| 4 | No Connection | | |

Ordering Information

| Device | Package | Shipping |
|---------|-----------------------|------------------|
| MAC12DG | TO 000 4 D | |
| MAC12MG | TO-220AB (Pb-Free) | 1000 Units / Box |
| MAC12NG | (1 5 1100) | |

2. Controlling dimension: inch.



^{1.} Dimensioning and tolerancing per ansi y14.5m, 1982.

^{3.} Dimension z defines a zone where all body and lead irregularities are allowed.